

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/749,577	<b>Applicant(s)/Patent under Reexamination</b> FUIMAONO ET AL.
	<b>Examiner</b> Lee S. Cohen	<b>Art Unit</b> 3739

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference Search History Printout		11/21/2005	LSC